


<b>Search Notes</b>  	<b>Application/Control No.</b>  10527736	<b>Applicant(s)/Patent Under Reexamination</b>  FOGG ET AL.
	<b>Examiner</b>  Tan Ho	<b>Art Unit</b>  2821

SEARCHED			
Class	Subclass	Date	Examiner
343	700MS, 742,767, 770	2/27/2008	TH

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	3/3/2008	TH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
343	700MS, 742	2/27/2008	TH
340	572.7	2/27/2008	TH